





EH25 45 ET T TS -1.8432M

Series —
RoHS Compliant (Pb-free) 5.0V 4 Pad 5mm x 7mm
Ceramic SMD HCMOS/TTL High Frequency Oscillator

Frequency Tolerance/Stability \_\_\_\_\_\_ ±50ppm Maximum

Operating Temperature Range --40°C to +85°C

Nominal Frequency
1.8432MHz
Pin 1 Connection

Tri-State (High Impedance)

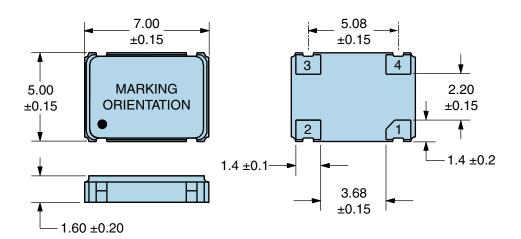
- Duty Cycle 50 ±5(%)

#50ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration)  Aging at 25°C  #5ppm/year Maximum  Operating Temperature Range  40°C to +85°C  Supply Voltage  5.0Vdc ±10%  Input Current  50mA Maximum (No Load)  Output Voltage Logic High (Voh)  2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH= -16mA)  Output Voltage Logic Low (Vol)  O.4Vdc Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  Duty Cycle  50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  Load Drive Capability  Output Logic Type  CMOS  Pin 1 Connection  Tri-State Input Voltage (Vih and Vil)  +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  #250pSec Maximum, ±30pSec Typical  Start Up Time  10mSec Maximum  10clusive of all conditions: Calibratic Algorithm (Prick Year Aging at 25°C, Shock, and Vibration)  #50ppm Maximum (Inclusive of all conditions: Calibratic Prick Year Aging at 25°C, Shock, and Vibration)  #50ppm Maximum (Inclusive Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration)  #50ppm Maximum (Inclusive Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock Algorithm (Prick Year Aging at 25°C, Algorithm	ELECTRICAL SPECIFICATIONS		
Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration)  45ppm/year Maximum  Operating Temperature Range 40°C to +85°C  Supply Voltage 5.0Vdc ±10%  Input Current 50mA Maximum (No Load)  Output Voltage Logic High (Voh) 0.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH= -16mA)  Output Voltage Logic Low (Vol) Rise/Fall Time 6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  Duty Cycle 50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  Load Drive Capability 10TTL Load or 50pF HCMOS Load Maximum  Output Logic Type CMOS  Pin 1 Connection Tri-State (High Impedance)  Tri-State Input Voltage (Vih and Vii) +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter ±250pSec Maximum, ±100pSec Typical  Start Up Time 10mSec Maximum	Nominal Frequency	1.8432MHz	
Operating Temperature Range  -40°C to +85°C  Supply Voltage  5.0Vdc ±10%  Input Current  50mA Maximum (No Load)  Output Voltage Logic High (Voh)  2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH= -16mA)  Output Voltage Logic Low (Vol)  0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOH= +16mA)  Rise/Fall Time  6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  Duty Cycle  50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  Load Drive Capability  10TTL Load or 50pF HCMOS Load Maximum  Output Logic Type  CMOS  Pin 1 Connection  Tri-State (High Impedance)  Tri-State Input Voltage (Vih and Vil)  +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter  ±250pSec Maximum, ±100pSec Typical  Start Up Time  10mSec Maximum	Frequency Tolerance/Stability	Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C,	
Supply Voltage 5.0Vdc ±10%  Input Current 50mA Maximum (No Load)  Output Voltage Logic High (Voh) 2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH= -16mA)  Output Voltage Logic Low (Vol) 0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOH= +16mA)  Rise/Fall Time 6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  Duty Cycle 50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  Load Drive Capability 10TTL Load or 50pF HCMOS Load Maximum  Output Logic Type CMOS  Pin 1 Connection Tri-State (High Impedance)  Tri-State Input Voltage (Vih and Vil) +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter ±250pSec Maximum, ±100pSec Typical  Start Up Time 10mSec Maximum	Aging at 25°C	±5ppm/year Maximum	
Input Current  50mA Maximum (No Load)  Output Voltage Logic High (Voh)  2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH= -16mA)  Output Voltage Logic Low (Vol)  0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOH= +16mA)  Rise/Fall Time  6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  Duty Cycle  50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  Load Drive Capability  10TTL Load or 50pF HCMOS Load Maximum  Output Logic Type  CMOS  Pin 1 Connection  Tri-State (High Impedance)  Tri-State Input Voltage (Vih and Vil)  +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter  ±250pSec Maximum, ±100pSec Typical  50mSec Maximum  10mSec Maximum  10mSec Maximum	Operating Temperature Range	-40°C to +85°C	
Output Voltage Logic High (Voh)  2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH= -16mA)  0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOH= +16mA)  Rise/Fall Time  6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  Duty Cycle  50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  Load Drive Capability  10TTL Load or 50pF HCMOS Load Maximum  Output Logic Type  CMOS  Pin 1 Connection  Tri-State (High Impedance)  +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter  2.50pSec Maximum, ±100pSec Typical  ±50pSec Maximum, ±30pSec Typical  Start Up Time  10mSec Maximum	Supply Voltage	5.0Vdc ±10%	
Output Voltage Logic Low (Vol)  0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOH= +16mA)  6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  Duty Cycle  50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  Load Drive Capability  10TTL Load or 50pF HCMOS Load Maximum  Output Logic Type  CMOS  Pin 1 Connection  Tri-State (High Impedance)  Tri-State Input Voltage (Vih and Vil)  +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter  1250pSec Maximum, ±100pSec Typical  ±50pSec Maximum, ±30pSec Typical  5tart Up Time  10mSec Maximum	Input Current	50mA Maximum (No Load)	
Rise/Fall Time  6nSec Maximum (Measured at 0.8Vdc to 2.0Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  Duty Cycle  50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  Load Drive Capability  10TTL Load or 50pF HCMOS Load Maximum  Output Logic Type  CMOS  Pin 1 Connection  Tri-State (High Impedance)  Tri-State Input Voltage (Vih and Vil)  +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter  ±250pSec Maximum, ±100pSec Typical  One Sigma Clock Period Jitter  ±50pSec Maximum, ±30pSec Typical  Start Up Time  10mSec Maximum	Output Voltage Logic High (Voh)	2.4Vdc Minimum with TTL Load, Vdd-0.4Vdc Minimum with HCMOS Load (IOH= -16mA)	
with HCMOS Load)  Duty Cycle 50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)  Load Drive Capability 10TTL Load or 50pF HCMOS Load Maximum  Output Logic Type CMOS  Pin 1 Connection Tri-State (High Impedance)  Tri-State Input Voltage (Vih and Vil) +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter ±250pSec Maximum, ±100pSec Typical  One Sigma Clock Period Jitter ±50pSec Maximum, ±30pSec Typical  Start Up Time 10mSec Maximum	Output Voltage Logic Low (Vol)	0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load (IOH= +16mA)	
Load Drive Capability     10TTL Load or 50pF HCMOS Load Maximum       Output Logic Type     CMOS       Pin 1 Connection     Tri-State (High Impedance)       Tri-State Input Voltage (Vih and Vil)     +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.       Absolute Clock Jitter     ±250pSec Maximum, ±100pSec Typical       One Sigma Clock Period Jitter     ±50pSec Maximum, ±30pSec Typical       Start Up Time     10mSec Maximum	Rise/Fall Time		
Output Logic Type  CMOS  Pin 1 Connection  Tri-State (High Impedance)  +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter  ±250pSec Maximum, ±100pSec Typical  One Sigma Clock Period Jitter  ±50pSec Maximum, ±30pSec Typical  10mSec Maximum	Duty Cycle	50 ±5(%) (Measured at 50% of waveform with TTL Load or with HCMOS Load)	
Pin 1 Connection  Tri-State (High Impedance)  Tri-State Input Voltage (Vih and Vil)  +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter  ±250pSec Maximum, ±100pSec Typical  One Sigma Clock Period Jitter  ±50pSec Maximum, ±30pSec Typical  Start Up Time  10mSec Maximum	Load Drive Capability	10TTL Load or 50pF HCMOS Load Maximum	
Tri-State Input Voltage (Vih and Vil) +2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.  Absolute Clock Jitter  ±250pSec Maximum, ±100pSec Typical  50pSec Maximum, ±30pSec Typical  10mSec Maximum  10mSec Maximum	Output Logic Type	CMOS	
enable output.  Absolute Clock Jitter ±250pSec Maximum, ±100pSec Typical  One Sigma Clock Period Jitter ±50pSec Maximum, ±30pSec Typical  Start Up Time 10mSec Maximum	Pin 1 Connection	Tri-State (High Impedance)	
One Sigma Clock Period Jitter ±50pSec Maximum, ±30pSec Typical  Start Up Time 10mSec Maximum	Tri-State Input Voltage (Vih and Vil)	+2.2Vdc Minimum to enable output, +0.8Vdc Maximum to disable output (High Impedance), No Connect to enable output.	
Start Up Time 10mSec Maximum	Absolute Clock Jitter	±250pSec Maximum, ±100pSec Typical	
·	One Sigma Clock Period Jitter	±50pSec Maximum, ±30pSec Typical	
Storage Temperature Range -55°C to +125°C	Start Up Time	10mSec Maximum	
	Storage Temperature Range	-55°C to +125°C	

ENVIRONMENTAL & MECHANICAL SPECIFICATIONS		
ESD Susceptibility	MIL-STD-883, Method 3015, Class 1, HBM: 1500V	
Fine Leak Test	MIL-STD-883, Method 1014, Condition A	
Flammability	UL94-V0	
Gross Leak Test	MIL-STD-883, Method 1014, Condition C	
Mechanical Shock	MIL-STD-883, Method 2002, Condition B	
Moisture Resistance	MIL-STD-883, Method 1004	
Moisture Sensitivity	J-STD-020, MSL 1	
Resistance to Soldering Heat	MIL-STD-202, Method 210, Condition K	
Resistance to Solvents	MIL-STD-202, Method 215	
Solderability	MIL-STD-883, Method 2003	
Temperature Cycling	MIL-STD-883, Method 1010, Condition B	
Vibration	MIL-STD-883, Method 2007, Condition A	



### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



PIN CONNECTION	
1	Tri-State
2	Ground
3	Output
4	Supply Voltage

LINE	MARKING
1	ECLIPTEK
2	1.8432M
3	XXXXXX XXXXXX=Ecliptek Manufacturing Identifier

#### **Suggested Solder Pad Layout**

All Dimensions in Millimeters



All Tolerances are ±0.1



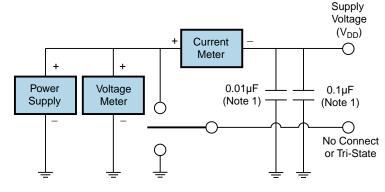
#### **OUTPUT WAVEFORM & TIMING DIAGRAM**

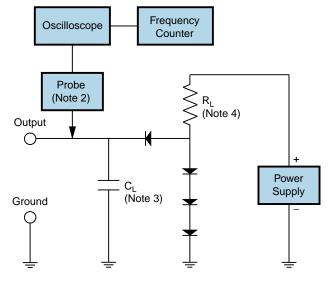


#### **Test Circuit for TTL Output**

Output Load Drive Capability	R <sub>L</sub> Value (Ohms)	C <sub>L</sub> Value (pF)
10TTL	390	15
5TTL	780	15
2TTL	1100	6
10LSTTL	2000	15
1TTL	2200	3

Table 1:  $R_L$  Resistance Value and  $C_L$  Capacitance Value Vs. Output Load Drive Capability





Note 1: An external  $0.1\mu F$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu F$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $C_{\mathsf{L}}$  includes sum of all probe and fixture capacitance.

Note 4: Resistance value R<sub>L</sub> is shown in Table 1. See applicable specification sheet for 'Load Drive Capability'.

Note 5: All diodes are MMBD7000, MMBD914, or equivalent.



#### **Test Circuit for CMOS Output**



Note 1: An external  $0.1\mu\text{F}$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu\text{F}$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $\dot{C}_L$  includes sum of all probe and fixture capacitance.



## **Recommended Solder Reflow Methods**



### **High Temperature Infrared/Convection**

<u> </u>	
T <sub>s</sub> MAX to T <sub>∟</sub> (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>S</sub> MIN)	150°C
- Temperature Typical (T <sub>s</sub> TYP)	175°C
- Temperature Maximum (T <sub>s</sub> MAX)	200°C
- Time (t <sub>s</sub> MIN)	60 - 180 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T <sub>P</sub> )	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T <sub>P</sub> Target)	250°C +0/-5°C
Time within 5°C of actual peak (tp)	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.



### **Recommended Solder Reflow Methods**



### Low Temperature Infrared/Convection 240°C

T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>s</sub> MIN)	N/A
- Temperature Typical (T <sub>s</sub> TYP)	150°C
- Temperature Maximum (T <sub>s</sub> MAX)	N/A
- Time (t <sub>s</sub> MIN)	60 - 120 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T <sub>P</sub> )	240°C Maximum
Target Peak Temperature (T <sub>P</sub> Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times
Time within 5°C of actual peak (tp)	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.

#### **Low Temperature Manual Soldering**

185°C Maximum for 10 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)